

# S2 Simulation with Garfield++

Thorsten Lux

# Workflow

Gmsh: 3D mesh generator and geometry definition

Elmer: Imports the mesh, allows to define the boundary conditions/potentials and solves the electric field map

Magboltz: calculates the transport properties for e for 60 different gases and their mixtures, includes excitation and ionization levels for all these gases

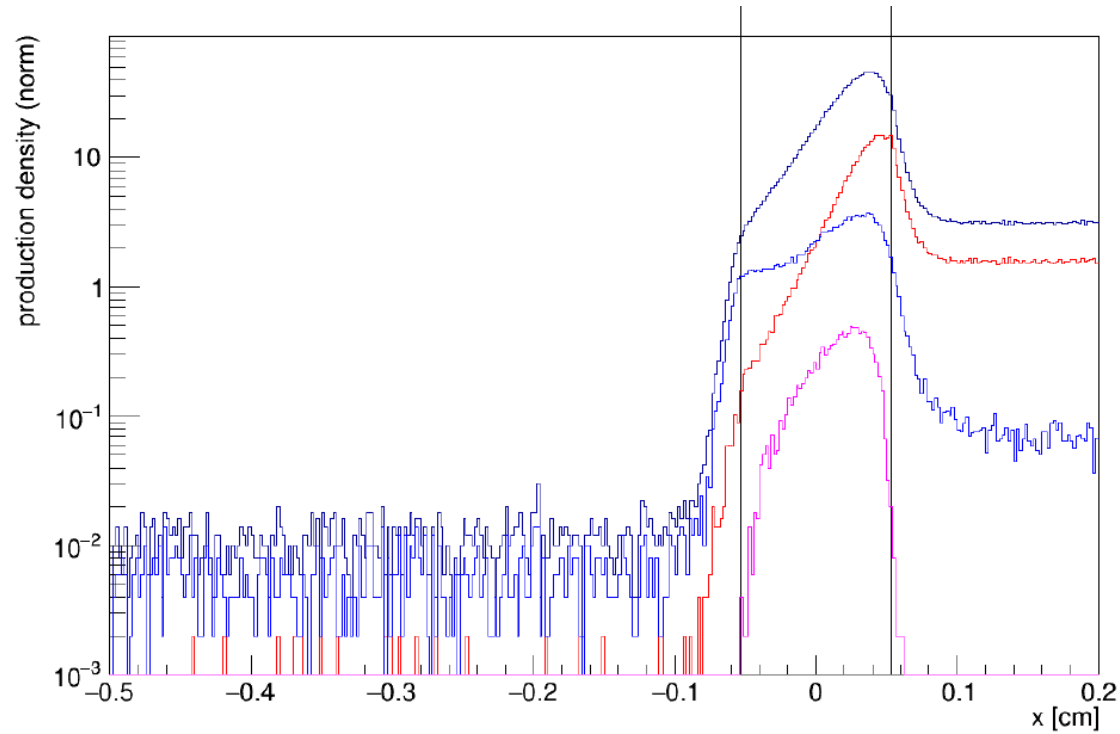
Garfield++: C++ framework with several classes to import the Elmer field maps and to do a microscopic MC transport of the e; allows to get back the position of any excitation or ionization

# Geometry, Fields and Analysis Strategy

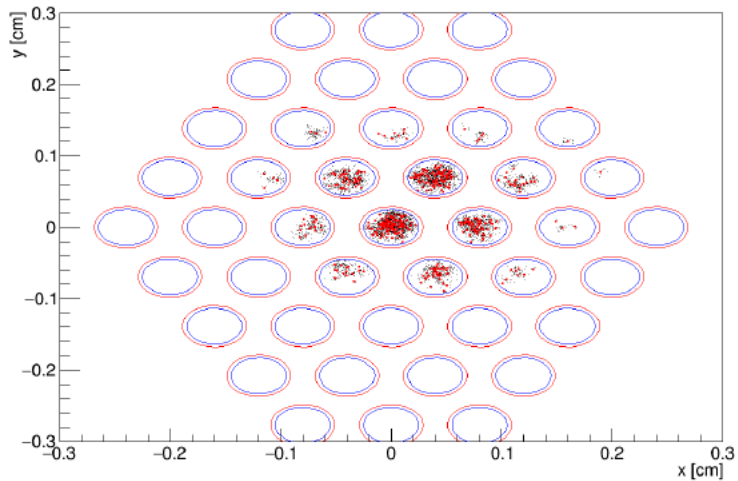
Strategy:

1. Place primary e- 0.49 cm below LEM, xy position randomized
2. Use Garfield++/Magboltz to drift and avalanche e-
3. Get back production point for ionization/excitation + end point of charged particles
4. Simulate at least 500 events per LEM voltage
5. Charge: calculate  $GTot/Geff/IBF$  from end point
6. Photons: propagate isotropic photons and check where they end wity pyRoot script
7. No charging up simulated

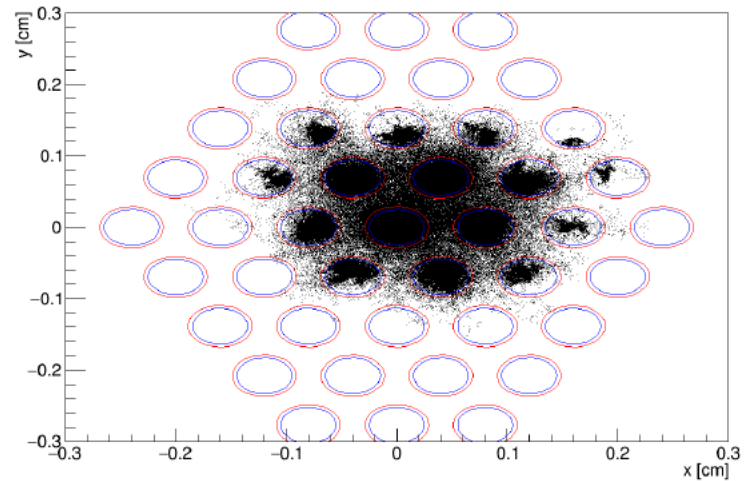
<b>Geometry</b>	
<b>Extraction gap</b>	5 mm
<b>Induction gap</b>	2 mm
<b>LEM dielectric thickness</b>	1 mm
<b>LEM copper thickness</b>	35 $\mu\text{m}$
<b>LEM dielectric hole radius</b>	250 $\mu\text{m}$
<b>LEM copper hole rim</b>	40 $\mu\text{m}$
<b>LEM hole pitch</b>	800 $\mu\text{m}$
<b>LEM hole arrangement</b>	hexagonal
<b>Field/Voltage</b>	
<b>Extraction field</b>	3 kV/cm
<b>Induction field</b>	5 kV/cm
<b>LEM Voltage</b>	2500 to 3500 V



**Figure 2:**  $z$  distribution of the production point of S2 photons (black) and ionizations (magenta) normalized to one event. The red curve shows the production point of the photons reaching the anode and in blue for the photons reaching the liquid surface. The vertical lines indicate the end of the position of the surfaces of the copper layers.



(a) Charge



(b) Photons

**Figure 3:** The event distribution in the  $xy$  plane, perpendicular to the liquid surface, for the ionizations (a) and the photons (b). Block points in (a) indicate single ionization events, while the red points indicate the centers of the avalanches. The plots show the accumulation of 500 events at 3300 V across the LEM. A correlation between the two processes is clearly visible although while the ionizations are limited to the holes, the photon production is much more spread. To guide the eye also the holes are drawn in the relevant region, blue the hole in the dielectric and in red the one in the copper.

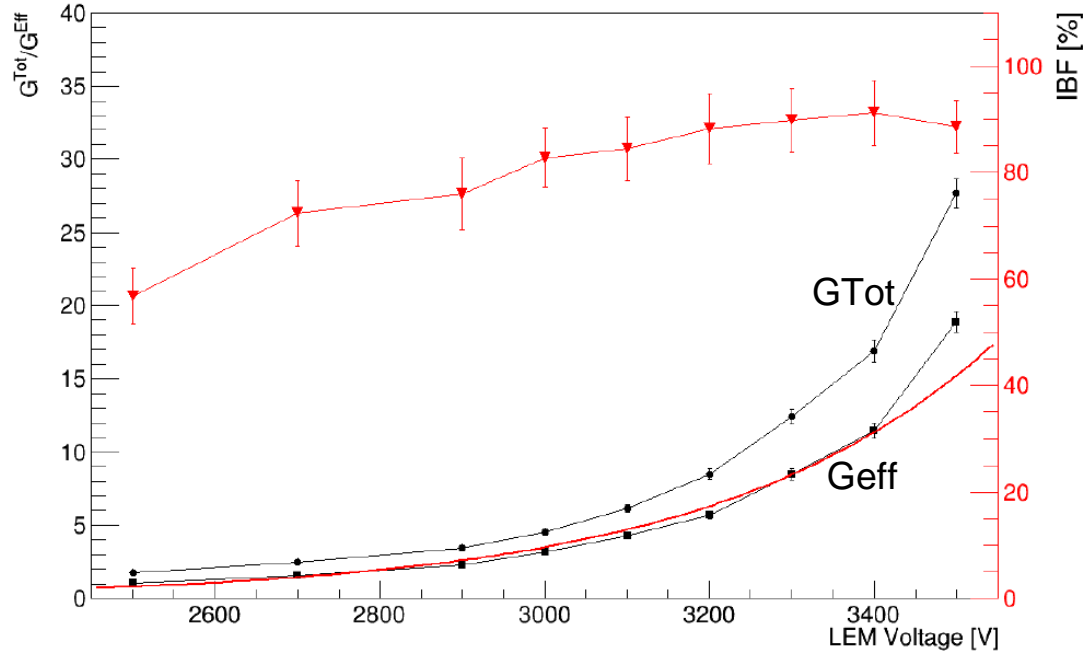
$$G^{Tot} = \frac{\# \text{ electrons produced}}{\# \text{ primary electrons}}$$

$$G^{Eff} = \frac{\# \text{ electrons reaching the anode}}{\# \text{ primary electrons}}$$

$$IBF = \frac{\# \text{ ions reaching the liquid}}{\# \text{ electrons reaching the anode}}$$

## Charge results:

- $G_{Tot}$  and  $G_{eff}$  seem to behave well (forget fit)
- maximal  $G_{eff}$  of about 13 at 3300 V before charging up
- $IBF$  is very high as predicted (see next slide), starts at about 60% and stabilized finally at around 90%



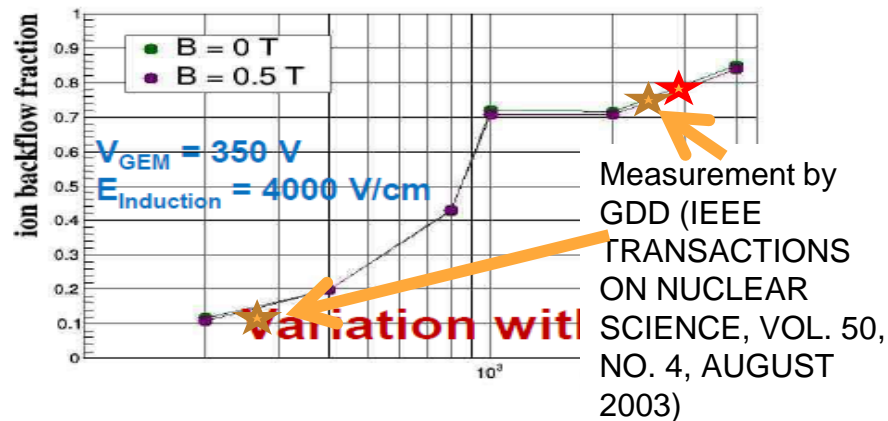
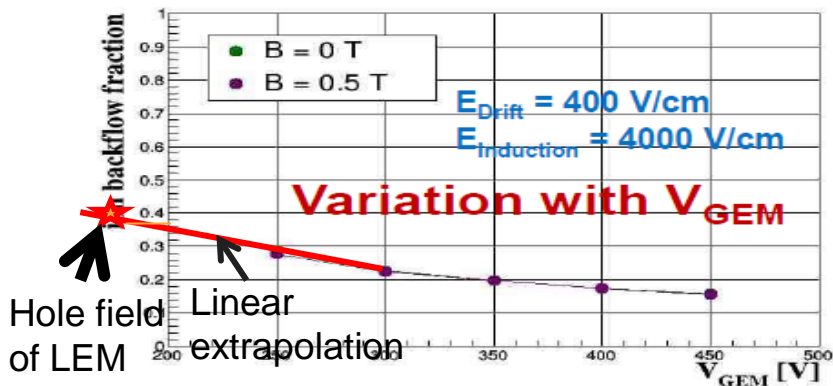
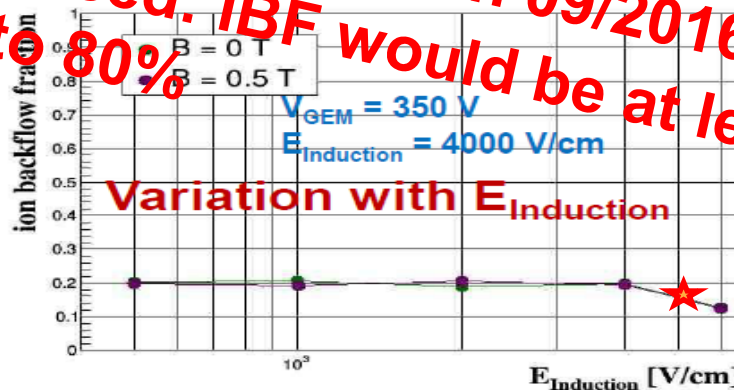
**Figure 4:** Total (black dots) and effective gain (black squares) in function of the applied LEM voltage. An exponential fit is added to  $G^{Eff}$  to show that the data follows the expected curve. In red also the  $IBF$  in respect to  $G^{Eff}$  is added. A high  $IBF$  of about 90% is observed for all LEM voltages.

# Simulations for GEMs

Did not find measurements for single THGEM and my simple simulations still not finished but there was an interesting talk by Purba Bhattacharya about simulation with single GEM (50  $\mu\text{m}$  thick).

=> Simulations should consider worst case scenario of IBF of 0.5 to 1!

**WA105 presentation 09/2016**  
**Guessed: IBF would be at least 70 to 80%**





# Possible Implications

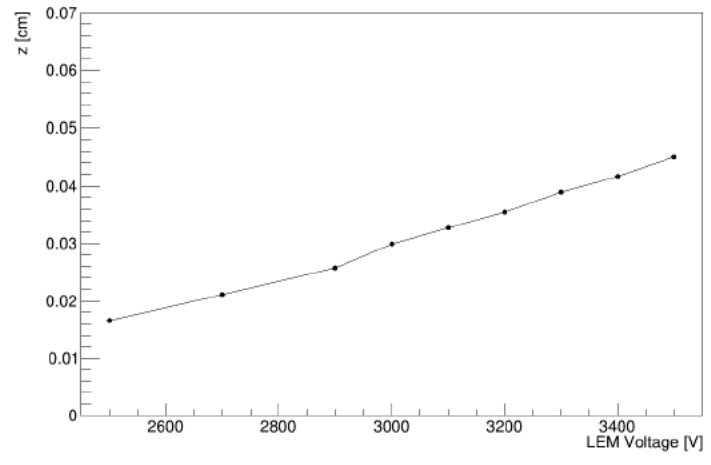
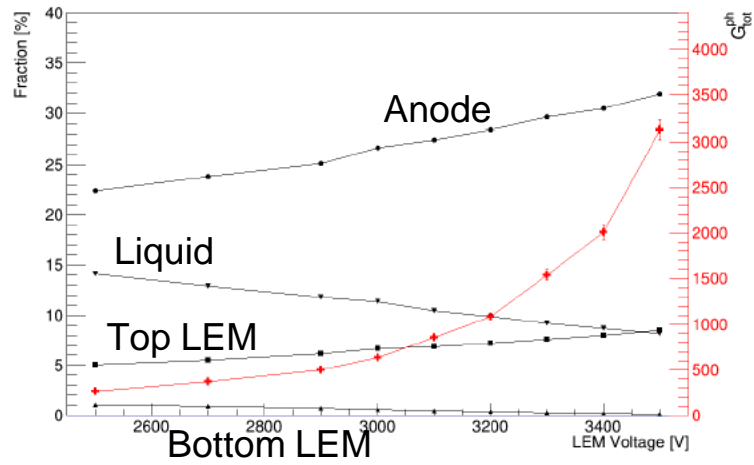
- Measurements in gas will provide IBF of LEM under close to real conditions
- Measurements with LAr will provide “ion gas to liquid transition probability” (IGLTP)

This is no “Fun R&D” (like testing other MPGDs to get a gain of 22 instead of 20) but could have serious impact on the design of WA105!

Case:

1. IBF < 10-20%: Safe and one continue as until now
2. IBF >> 10% && IGLTP low: ions are transported by convection but charging up in the gas extraction region might be huge, especially for 6x6 m<sup>2</sup> => Do we will need electrodes for the ions around each LEM?
3. IBF >> 10%&&IGLTP high: ions go into the liquid and the field distortions will be enormous => Do we need a gate? How could it be realized?

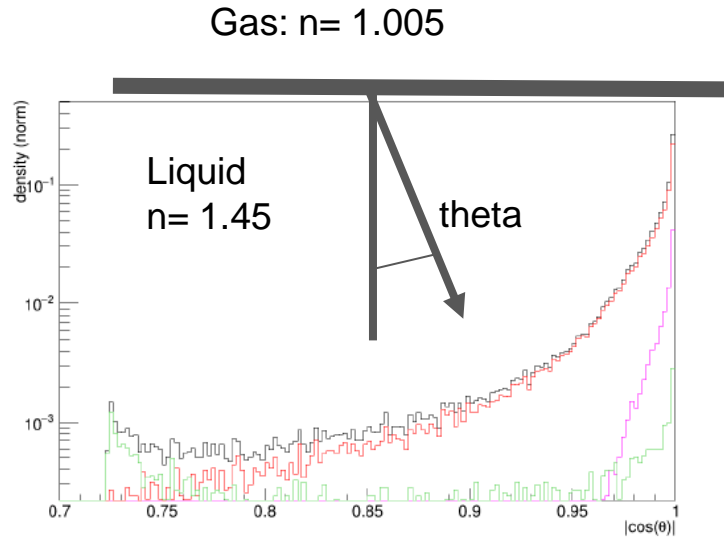
Photon results: #Photons reaching liquid @ 3300 V about 160



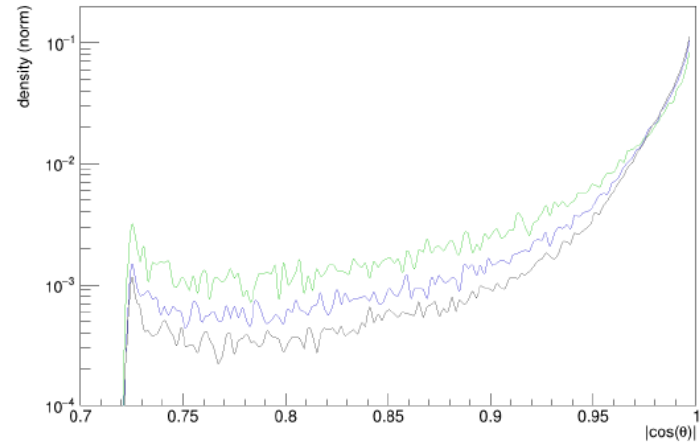
(a)  $G_{Ph}^{Tot}$  and photon end point distribution.

(b)  $z$  mean production position versus LEM voltage

**Figure 5:** (a) The total photon gain in function of the LEM voltage (red). Also the fractions of the total photons ending on one of the 3 electrodes, anode (dots) and top (square) and bottom side (up triangle) of the LEM or reaching the liquid argon surface (down triangle) in function of the LEM voltage. (b) Shifting of the mean  $z$  position of the photon production in function of the applied LEM voltage.



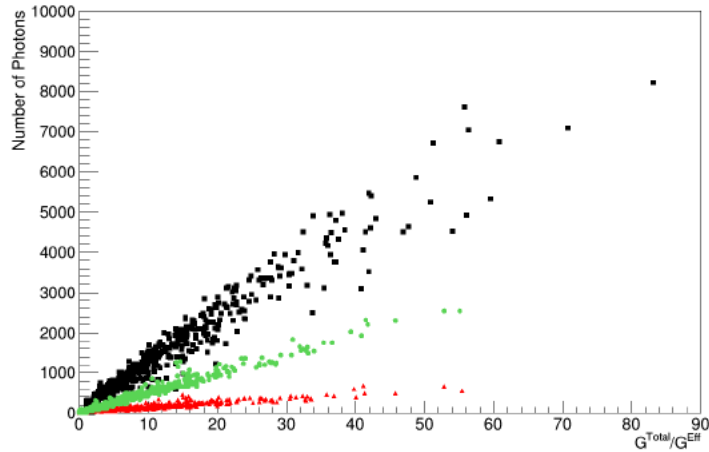
(a) Opening angle contributions



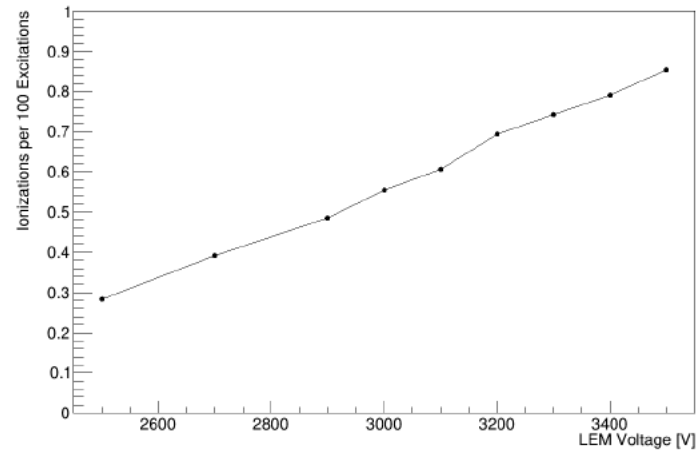
(b) Opening angle relation to LEM voltage

**Figure 6:** (a) Absolute value of the cosine of the opening angle of the photon cone inside the liquid argon assuming a wavelength of 128 nm,  $n^{gas} = 1.0005$  and  $n^{liq} = 1.45$ . Also the distributions of the different photon productions regions is shown: photons from the extraction region (green), from inside the holes (red) and from the induction region (blue). (b) The same distribution for different LEM voltages: 2900 V (red), 3300 V (blue) and 3500 V (black).

# Correlations between charge and light



(a) Charge versus photon gain

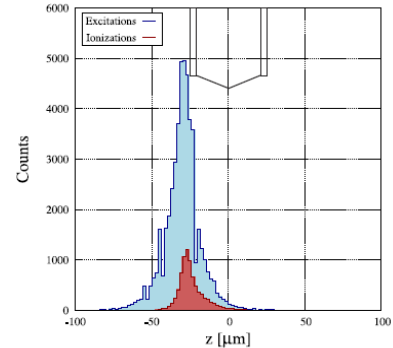


(b) Number of ionizations per 100 excitations.

**Figure 7:** (a) Charge versus photon gain:  $G^{Tot}$  versus  $G_{Ph}^{Tot}$  (black),  $G^{Eff}$  versus photons reaching the anode (green) and  $G^{Eff}$  versus photons reaching the liquid (red).

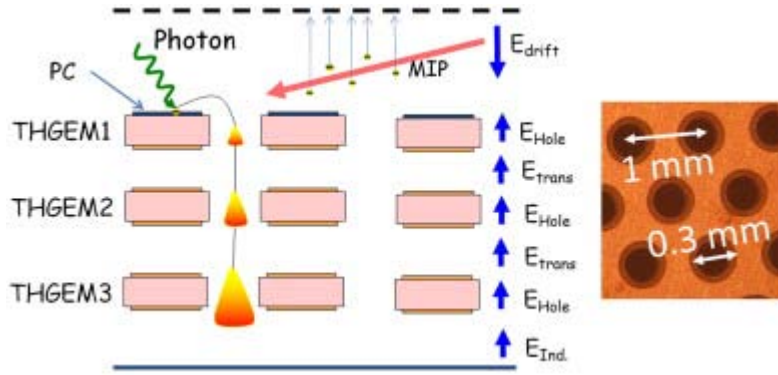
# Discrepancy between data and simulation:

- simulated gain at 3300 V is around 7-8, while the reported one is about 65 (both before charging up)
- Checked Magboltz gas file and it confirms that I simulated 1 bar argon at 90 K.
- Voltages reported when Garfield++ simulation starts are also agreeing with expectations
- Beside of gain simulations give consistent results and fulfil expectations based on other studies
- if boosting gain, amount of S2 is also boosted accordingly  
=> would be big problem
- Could it be Photon-Feedback?



(d)  $V_{\text{GEM}} = 500 \text{ V}$

- Photo Feedback well known process since decades
- high energetic photons from S2, about 10 eV, “perfect” for PF
- possible electrodes: Top and bottom of LEM
- Bottom LEM: few photons in extraction gap per primary e but high electric fields to extract them and these could undergo full amplification process and therefore would have quite an impact on  $G_{eff}$  => would double ions and photons roughly
- TOP LEM: much more photons but lower E fields and only 2 mm direct way to anode => no additional ions, but possible additional feedback from released e, few photons would reach liquid (shielded by LEM)



- same principle is used in RICH detectors
- longer wavelength and therefore photosensitive coating but the principle is the same
- for 128 nm this can happen without coating

- Implications on gain curve: a) more gain than expected from exponential at lower voltages since even without amplification due to primary e which could produce PF in induction region b) positive feedback and change of mean photon production point towards induction gap should lead to over exponential for high LEM voltages => these features seem to be in ETH data
- Implications II: gain should depend strongly on induction field => if extraction == induction field no PF => strong effect for GEM in pure argon reported as also over exponential gain curve

## High gain operation of GEM in pure argon

A.Bressan<sup>a</sup>, A.Buzulutskov<sup>a\*</sup>, L.Ropelewski<sup>a</sup>, F.Sauli<sup>a</sup>, L.Shekhtman<sup>b</sup>

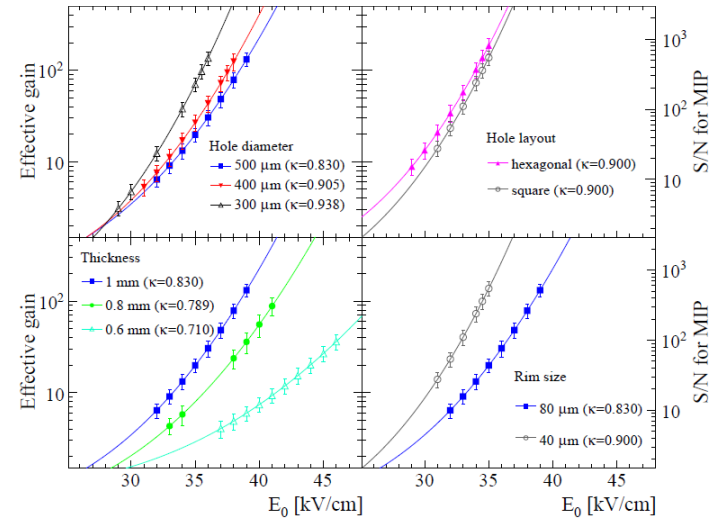
<sup>a</sup>CERN, Geneva, Switzerland

<sup>b</sup>Budker Institute of Nuclear Physics, Novosibirsk, Russia

### Abstract

We study the operation of the Gas Electron Multiplier (GEM) in pure Ar, in comparison to that in Ar-CO<sub>2</sub> mixture. In pure Ar, high GEM gains, of above 700 and 3000 for single and double GEM structures correspondingly, have been obtained. It is observed that the GEM effective gain and its charging-up are strongly affected by electric field values above and below the GEM. Applications to the development of non-ageing gas photomultiplier are discussed.

### Performance study of the effective gain of the double phase liquid Argon LEM Time Projection Chamber



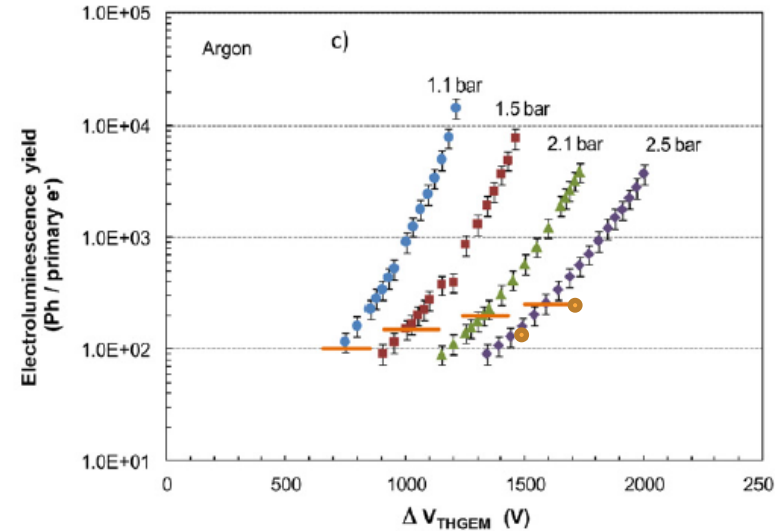
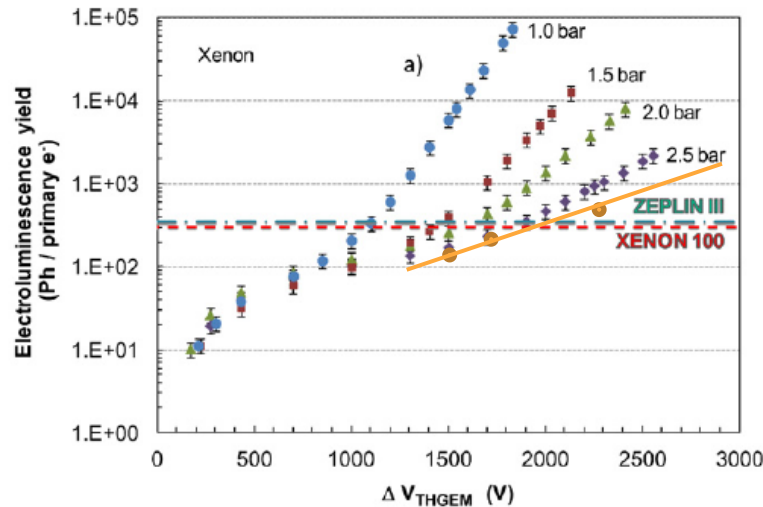
- Over exponential also observed in EL study with THGEM
- Simulated their geometry with argon and xenon
- 1500 V agrees with argon data and 1500 + 1700 V with xenon
- Divergence for higher voltages
- Larger for argon
- Expected for PF since less Xe S2 and less energetic

Secondary scintillation yield from GEM and THGEM gaseous electron multipliers for direct dark matter search

C.M.B. Monteiro<sup>a,+</sup>, L.M.P. Fernandes<sup>a</sup>, J.F.C.A. Veloso<sup>a,b</sup>, C.A.B. Oliveira<sup>b</sup>, J.M.F. dos Santos<sup>a</sup>

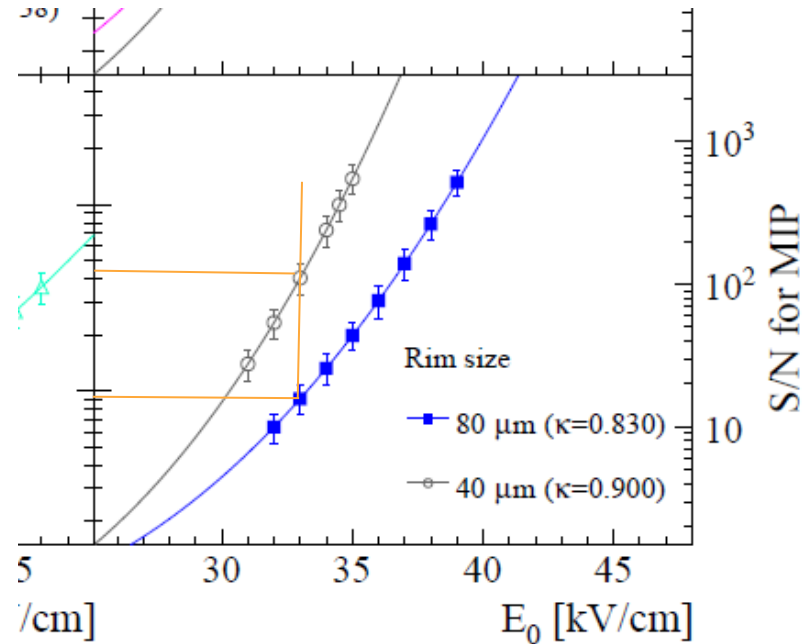
<sup>a</sup> CI, Physics Department, University of Coimbra, 3004-516 Coimbra, Portugal

<sup>b</sup> I3N, Physics Department, University of Aveiro, 3810-193 Aveiro, Portugal





- big effect on gain by doubling rim size
- simulated this geometry and compared with 40  $\mu\text{m}$  result
- charge gain dropped by 40% but should have dropped by 80%
- light gain also dropped by 40%
- in addition probability for PF reduced due to larger rim
- also shape of curve changed by rim
- might be another hint for relevant PF in the system



# High gain operation of GEM in pure argon

A.Bressan<sup>a</sup>, A.Buzulutskov<sup>b\*</sup>, L.Ropelewski<sup>a</sup>, F.Sauli<sup>a</sup>, L.Shekhtman<sup>b</sup>

<sup>a</sup> CERN, Geneva, Switzerland

<sup>b</sup> Budker Institute of Nuclear Physics, Novosibirsk, Russia

- in 1990 reported gains of 500 with single gain in pure argon
- interesting since measured pure argon and Ar:CO<sub>2</sub>
- Ar:CO<sub>2</sub> exponential behaviour, while pure argon not
- CO<sub>2</sub> highly absorbing for VUV photons  
=> Measurement of avalanche gain + PF (pure argon) and only avalanche gain (Ar:CO<sub>2</sub>)

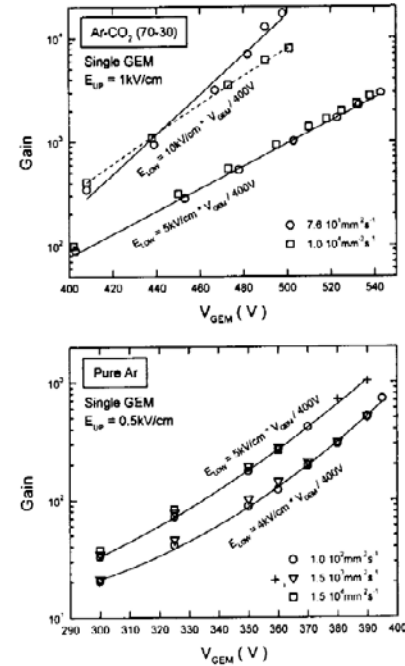


Figure 2 Effective gain of a single GEM as a function of GEM voltage measured in Ar-CO<sub>2</sub> and in pure Ar at different rates and different  $E_{LOW}$ . The exposed area of the detector was 40 cm<sup>2</sup>, except of the last two data points in Ar plot (cross symbols) where it was reduced to 2 mm<sup>2</sup>.

- PF must exist in this readout scheme
- Widely described in early works
- In “Feedback and Breakdown ...” also over-exponential behaviour is described
- In “Electron ionization ...” the PF is attributed a higher gain at low voltages than expected
- Open question is it the dominant gain production process? Or at least relevant?

If there is a large amount of feedback the total gain will increase over-exponentially, because (eq.(3))  $G_t(E) = G(E)/(1 - \eta G(E))$ . The deviation of  $G_t(E)$  from an exponential behavior allows an estimation of the feedback level  $\eta$ . This method depends only on the total charge in the avalanche and thereby it can be used also for gases containing He.

# Feedback and Breakdown in Parallel-plate Chambers

P.Fonte<sup>1,2)</sup>, V.Peskov<sup>2,3)</sup>, and F.Sauli<sup>2)</sup>

## Electron ionization and excitation coefficients for argon, krypton, and xenon in the low $E/N$ region

L. T. Specht

*Department of Chemistry and Coordinated Science Laboratory, University of Illinois, Urbana, Illinois 61801*

S. A. Lawton<sup>4)</sup> and T. A. DeTemple

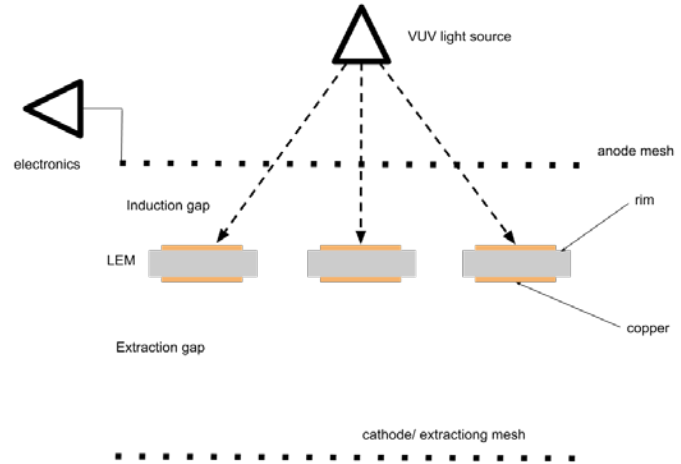
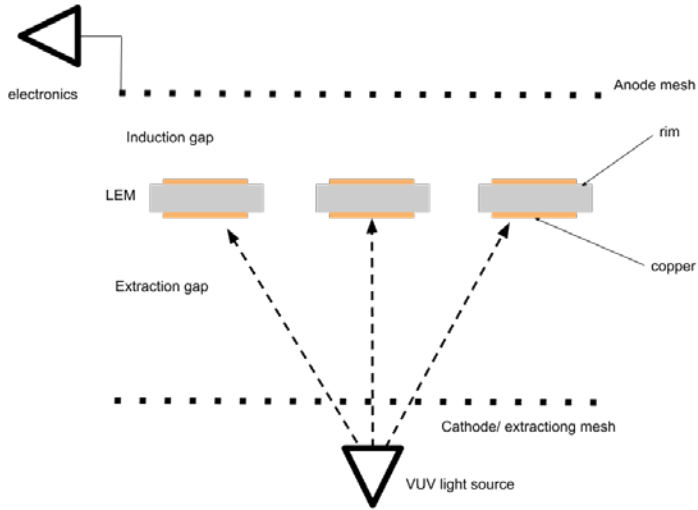
*Electro-Physics Laboratory, Department of Electrical Engineering, and Coordinated Science Laboratory, University of Illinois, Urbana, Illinois 61801*

(Received 25 June 1979; accepted for publication 7 August 1979)

The electron ionization coefficients for Ar, Kr, and Xe have been measured in the low  $E/N$  region  $[(0.5-4) \times 10^{-16} \text{ V cm}^2]$  using a drift-tube apparatus. At low field values, the ionization coefficient was found to be anomalously large, a fact attributed to surface photoelectron emission from radiating metastables. This contribution also explains the discrepancy between earlier measurements and recent calculations based on the transport equation. The measurements were analyzed on the basis of two contributions to the ionization rate and calculations of the transport equation, yielding a revised set of inelastic cross sections which differ from earlier ones primarily in the inclusion of shape resonances.

# PF could and should be studied

- could be simple setup
- VUV light source, Xe lamp or EL detector, + detector with transparent meshes
- anode mesh would have to read out



# Summary

- Simulation results consistent and fulfill expectations
- IBF very high as expected from GEM simulations by other groups
- Problem: simulated gain much lower than observed one
- Photon-feedback could explain the difference? Shape of gain curves certainly ... hints towards this in results from 3 studies
- If PF is dominated factor for gain production, there is a big problem => highly sensitive to settings and gas quality => stable operation on large scale might be difficult with current design
- **But also might be an opportunity: there might be an optimized scheme with high gain with limited IBF and not pushing the voltages for avalanche gain to the limit**